

Search Notes

Application/Control No.

10/715,261

Examiner

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Applicant(s)/Patent under Reexamination

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Art Unit

2613

SEARCHED

Class	Subclass	Date	Examiner
398	169	08/30/07	HP
	170		
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	118 128, 130		
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**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
East Search see attached printout in the file.	08/30/07	HP
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398	169, 170 135, 118 128, 130	08/30/07	HP
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